

Substitute for form 1449B/PTO			<b>Complete if Known</b> <b>Application Number</b> 10/550,157 <b>Filing Date</b> September 20, 2005 <b>First Named Inventor</b> Majd ALWAN et al. <b>Art Unit</b> 3736 <b>Examiner Name</b> John PANI <b>Attorney Docket Number</b> 00765-04	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> (Use as many sheets as necessary)				
Sheet	1	of	2	

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages of Relevant Figures Appear
		Number Kind Code <sup>2</sup> (if known)			
	AA	US-6,909,373	06-21-2005	Power et al.	
	AB	US-6,360,597 B1	03-26-2002	Hubbard, Jr.	
	AC	US-6,301,964 B1	10-16-2001	Fyle et al.	
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	ACC	US-4,144,588	03-13-1979	Hiller et al.	
	ADD	US-6,696,956 B1	02-24-2004	Uchida et al.	
Examiner Signature				Date Considered	

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> Applicant is to place a check mark here if English language Translation is attached.

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			<b>Art Unit</b>	3736	
			<b>Examiner Name</b>	John PANI	
<b>Sheet</b>	<b>2</b>	<b>of</b>	<b>2</b>	<b>Attorney Docket Number</b>	00765-04

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	AEE	US-6,687,424 B1	02-03-2004	Gerdt et al.	
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	AOO	US-Patent Application Pub. 2002/0107649 A1	08-08-2002	Taguchi et al.	

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		Country Code <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup> (if known)		
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